MOSFET – Power 40 V, 111 A, 4.2 m Ω

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter		Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	40	٧	
Gate-to-Source Voltage			V_{GS}	±20	V	
Continuous Drain Current R _{0.1A}		T _A = 25°C	I _D	20	Α	
(Note 1)		T _A = 70°C		16		
Power Dissipation		T _A = 25°C	P_{D}	3.1	W	
R _{θJA} (Note 1)	Steady	T _A = 70°C		1.9		
Continuous Drain	State	T _C = 25°C	I _D	111	Α	
Current R _{θJC} (Note 1)		T _C = 70°C		89		
Power Dissipation		T _C = 25°C	P_{D}	96	W	
R _{θJC} (Note 1)		T _C = 70°C		61		
Pulsed Drain Current	t _p = 10 μs		I _{DM}	443	Α	
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C	
Source Current (Body Diode)			I _S	111	Α	
Single Pulse Drain-to-Source Avalanche		EAS	134	mJ		
Energy (L = 0.1 mH)			IAS	52	Α	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)				TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{ heta JC}$	1.3	
Junction-to-Ambient Steady State (Note 1)	$R_{ heta JA}$	40	°C/W
Junction-to-Ambient Steady State (Note 2)	$R_{\theta JA}$	75	

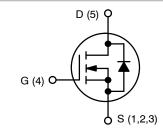
- 1. Surface-mounted on FR4 board using 1 sq-in pad (Cu area = 1.127 in sq [2 oz] inclusing traces).
- 2. Surface-mounted on FR4 board using 0.155 in sq (100mm²) pad size.



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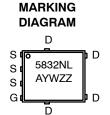
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	4.2 mΩ @ 10 V	111 A
40 V	6.5 mΩ @ 4.5 V	11170



N-CHANNEL MOSFET



DFN5 (SO-8FL) CASE 488AA STYLE 1



A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS5832NLT1G	DFN5 (Pb-Free)	1500/Tape & Reel

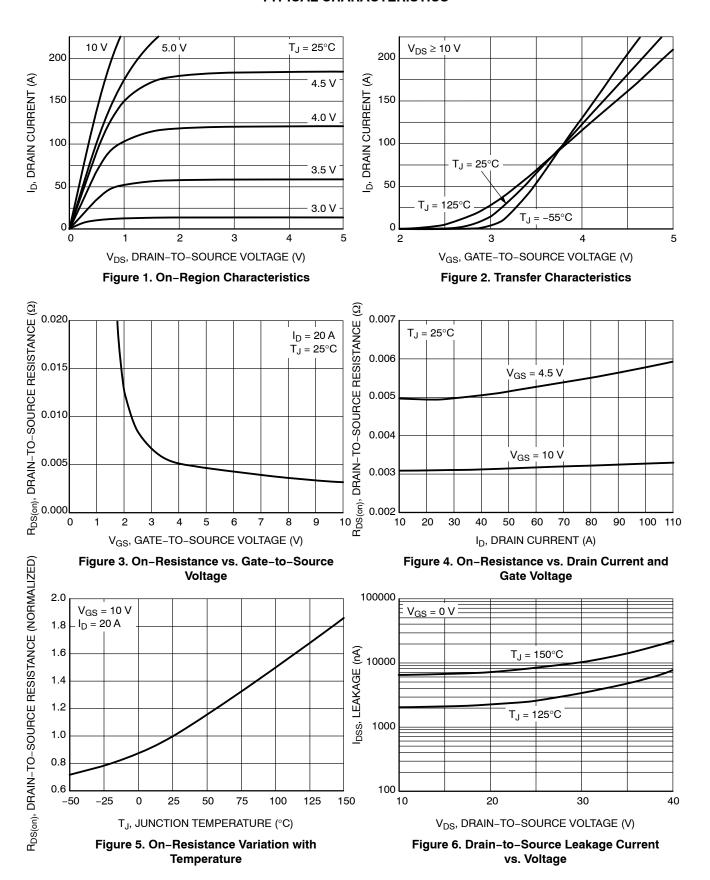
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS					•	•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				34.2		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 40 V	T _J = 25 °C			1		
			T _J = 125°C			100	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA	
ON CHARACTERISTICS (Note 3)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.0		3.0	V	
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.4		mV/°0	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 20 A		3.1	4.2	mΩ	
		V _{GS} = 4.5 V	I _D = 20 A		5.0	6.5		
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _E) = 20 A		21		S	
CHARGES, CAPACITANCES & GATE RESIS	STANCE							
Input Capacitance	C _{ISS}				2700			
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	z, V _{DS} = 25 V		360		pF	
Reverse Transfer Capacitance	C _{RSS}				250		1	
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 20 \text{ V}; I_D = 20 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V}; I_D = 20 \text{ A}$			25		nC	
Total Gate Charge	Q _{G(TOT)}				51			
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 20 V; I _D = 20 A			2.0			
Gate-to-Source Charge	Q_{GS}				8.0			
Gate-to-Drain Charge	Q_{GD}				12.7			
Plateau Voltage	V_{GP}				3.2		V	
Gate Resistance	R_{G}				1.2		Ω	
SWITCHING CHARACTERISTICS (Note 4)								
Turn-On Delay Time	t _{d(ON)}				13			
Rise Time	t _r	V _{GS} = 4.5 V, V _C	_{IS} = 20 V,		24		ns	
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{D} I_{D} = 10 A, R_{G}	= 1.0 Ω		27			
Fall Time	t _f				8.0			
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V},$ $I_{D} = 10 \text{ A}, R_{G} = 1.0 \Omega$			10			
Rise Time	t _r				18		1	
Turn-Off Delay Time	t _{d(OFF)}				32		ns	
Fall Time	t _f				5.0		L	
DRAIN-SOURCE DIODE CHARACTERISTIC	s							
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.73	1.2		
		I _S = 5 A	T _J = 125°C		0.57		- V	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$			28.6			
Charge Time	t _a				14		ns	
Discharge Time	t _b				14.5			
Reverse Recovery Charge	Q _{RR}				23.4		nC	

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

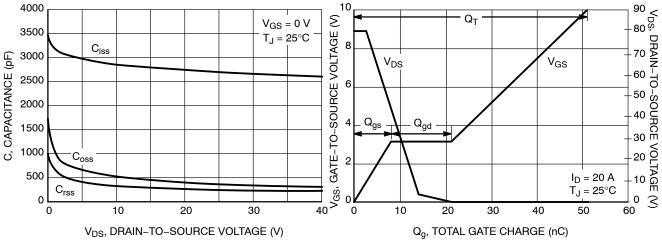


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Total Charge

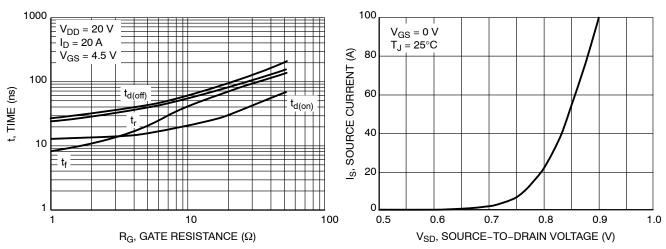


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

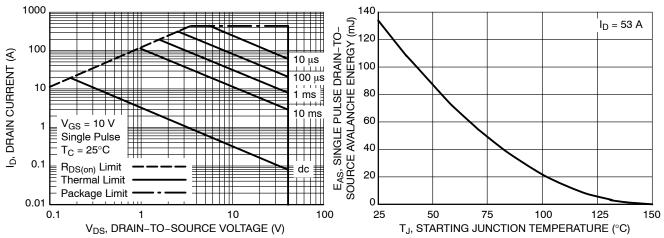


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

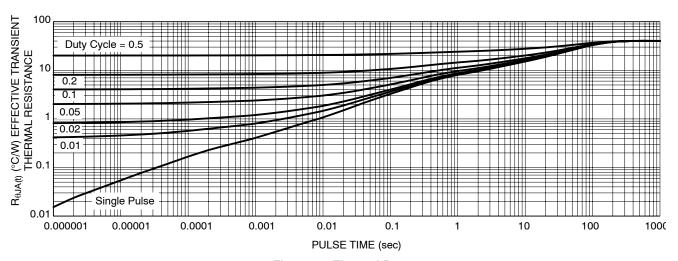


Figure 13. Thermal Response





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*

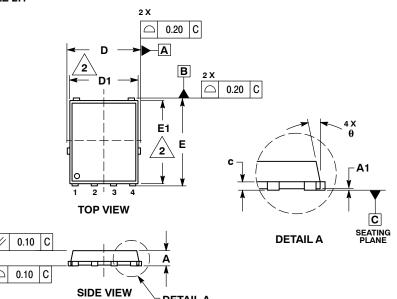


XXXXXX = Specific Device Code

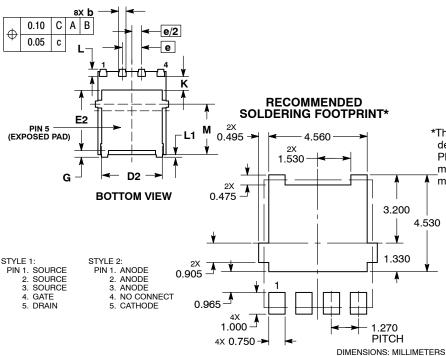
= Assembly Location Α

Υ = Year W = Work Week = Lot Traceability ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.



DETAIL A



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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